

Form PTO-1449

# INFORMATION DISCLOSURE CITATION IN AN APPLICATION

(Use several sheets if necessary)

Docket Number  
12-1054

Application Number

NA

Applicant  
Murduck, et al.

10/670/01

Filing Date  
Herewith

Group Art Unit

NA 285

## U. S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROP.
EN	5	4	6	3	2	5	4	10/31/95	Iyer, et al.			
	5	0	2	6	5	7	4	06/25/91	Economu, et al.			
	5	6	1	8	4	4	6	04/08/97	Nagaishi			
	5	5	6	0	8	3	6	10/01/96	Nagaishi			
	5	0	5	1	6	2	7	09/24/91	Schneier, et al.			
	4	0	9	2	5	5	3	05/30/78	Fang, et al.			
	4	5	0	1	9	7	5	02/26/85	Josephs, et al.			
	4	3	7	1	7	9	6	02/01/83	Takada			
	5	8	9	2	2	4	3	04/06/99	Chan			
	5	9	4	2	9	9	7	08/24/99	Silver, et al.			
EN	5	5	5	2	7	3	5	09/03/96	Kang, et al.			

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	Translation	
						Yes	No

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)


EXAMINER

EN

DATE CONSIDERED

A-7-04

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.

Sheet 2 of 2

Form PTO-1449

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Applicant  
Murduck, et al.

Group Art Unit  
2815

**U. S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER							DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROP.
EF	5	4	1	1	9	3	7	05/02/95	Wendt, et al.			
	5	5	6	0	8	3	6	10/01/96	Nagaishi			
	5	2	7	8	1	4	0	01/11/94	Chaudhari, et al.			
	4	7	8	5	4	2	6	11/15/88	Harada, et al.			
	5	1	3	5	9	0	8	08/04/92	Yang, et al.			
	5	2	2	5	3	9	4	07/06/93	Yamazaki			
	5	2	4	8	6	5	8	09/28/93	Yamazaki			
	4	9	8	5	1	1	7	01/15/91	Kurosawa, et al.			
	5	2	4	8	6	5	7	09/28/93	Bailey, et al.			
	5	1	9	6	3	9	5	03/23/93	James, et al.			
EF	5	5	6	7	3	3	0	10/22/96	Dorothy			

**FOREIGN PATENT DOCUMENTS**

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB CLASS	Translation	
						Yes	No

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)

EF	"Stationary Properties of High-Critical-Temperature Proximity Effect Josephson Junctions" by K. A. Delin and A. W. Kleinsasser, <i>Supercond. Sci. Technol.</i> 9 (1996) pgs 227-240.
EF	"Use of Paramagnetic or Other Impurities in Josephson Technology" by P. Wolf, <i>IBM Technical Disclosure Bulletin</i> Vol. 18, No. 8 (January 1976) page 2645.

EXAMINER

E. H.

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